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### Understanding **Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### Details

Product Status	Active
Number of LABs/CLBs	45525
Number of Logic Elements/Cells	582720
Total RAM Bits	29306880
Number of I/O	850
Number of Gates	-
Voltage - Supply	0.97V ~ 1.03V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	1760-BBGA, FCBGA
Supplier Device Package	1761-FCBGA (42.5x42.5)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc7v585t-2ffg1761c">https://www.e-xfl.com/product-detail/xilinx/xc7v585t-2ffg1761c</a>

**Table 1: Absolute Maximum Ratings<sup>(1)</sup> (Cont'd)**

Symbol	Description	Min	Max	Units
$V_{MGTAVTTRCAL}$	Analog supply voltage for the resistor calibration circuit of the GTX/GTH transceiver column	-0.5	1.32	V
$V_{IN}$	Receiver (RXP/RXN) and Transmitter (TXP/TXN) absolute input voltage	-0.5	1.26	V
$I_{DCIN}$	DC input current for receiver input pins DC coupled $V_{MGTAVTT} = 1.2V$	-	14	mA
$I_{DCOUT}$	DC output current for transmitter pins DC coupled $V_{MGTAVTT} = 1.2V$	-	14	mA
<b>XADC</b>				
$V_{CCADC}$	XADC supply relative to GNDADC	-0.5	2.0	V
$V_{REFP}$	XADC reference input relative to GNDADC	-0.5	2.0	V
<b>Temperature</b>				
$T_{STG}$	Storage temperature (ambient)	-65	150	°C
$T_{SOL}$	Maximum soldering temperature for Pb/Sn component bodies <sup>(6)</sup>	-	+220	°C
	Maximum soldering temperature for Pb-free component bodies <sup>(6)</sup>	-	+260	°C
$T_j$	Maximum junction temperature <sup>(6)</sup>	-	+125	°C

**Notes:**

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.
- The lower absolute voltage specification always applies.
- For I/O operation, refer to the *7 Series FPGAs SelectIO Resources User Guide* ([UG471](#)).
- The maximum limit applies to DC signals. For maximum undershoot and overshoot AC specifications, see [Table 4](#) and [Table 5](#).
- See [Table 10](#) for TMD5\_33 specifications.
- For soldering guidelines and thermal considerations, see the *7 Series FPGA Packaging and Pinout Specification* ([UG475](#)).

**Table 2: Recommended Operating Conditions<sup>(1)(2)</sup>**

Symbol	Description	Min	Typ	Max	Units
<b>FPGA Logic</b>					
$V_{CCINT}^{(3)}$	Internal supply voltage	0.97	1.00	1.03	V
	Internal supply voltage for -1C devices with voltage identification (VID) bit programmed to run at 0.9V typical <sup>(4)</sup> .	0.87	0.90	0.93	V
$V_{CCBRAM}^{(3)}$	Block RAM supply voltage	0.97	1.00	1.03	V
	Block RAM supply voltage for -1C devices with voltage identification (VID) bit programmed to run at 0.9V typical <sup>(4)</sup> .	0.87	0.90	1.03	V
$V_{CCAUX}$	Auxiliary supply voltage	1.71	1.80	1.89	V
$V_{CCO}^{(5)(6)}$	Supply voltage for 3.3V HR I/O banks	1.14	-	3.465	V
	Supply voltage for 1.8V HP I/O banks	1.14	-	1.89	V
$V_{CCAUX\_IO}$	Auxiliary supply voltage when set to 1.8V	1.71	1.80	1.89	V
	Auxiliary supply voltage when set to 2.0V	1.94	2.00	2.06	V
$V_{IN}^{(7)}$	I/O input voltage	-0.20	-	$V_{CCO} + 0.2$	V
	I/O input voltage (when $V_{CCO} = 3.3V$ ) for $V_{REF}$ and differential I/O standards except TMD5_33 <sup>(8)</sup>	-0.20	-	2.625	V
$I_{IN}^{(9)}$	Maximum current through any pin in a powered or unpowered bank when forward biasing the clamp diode.	-	-	10	mA
$V_{CCBATT}^{(10)}$	Battery voltage	1.0	-	1.89	V

Table 2: Recommended Operating Conditions<sup>(1)(2)</sup> (Cont'd)

Symbol	Description	Min	Typ	Max	Units
<b>GTX and GTH Transceivers</b>					
V <sub>MGTAVCC</sub> <sup>(11)</sup>	Analog supply voltage for the GTX/GTH transceiver QPLL frequency range ≤ 10.3125 GHz <sup>(12)(13)</sup>	0.97	1.0	1.08	V
	Analog supply voltage for the GTX/GTH transceiver QPLL frequency range > 10.3125 GHz	1.02	1.05	1.08	V
V <sub>MGTAVTT</sub> <sup>(11)</sup>	Analog supply voltage for the GTX/GTH transmitter and receiver termination circuits	1.17	1.2	1.23	V
V <sub>MGTVCCAUX</sub> <sup>(11)</sup>	Auxiliary analog Quad PLL (QPLL) voltage supply for the transceivers	1.75	1.80	1.85	V
V <sub>MGTAVTTRCAL</sub> <sup>(11)</sup>	Analog supply voltage for the resistor calibration circuit of the GTX/GTH transceiver column	1.17	1.2	1.23	V
<b>XADC</b>					
V <sub>CCADC</sub>	XADC supply relative to GNDADC	1.71	1.80	1.89	V
V <sub>REFP</sub>	Externally supplied reference voltage	1.20	1.25	1.30	V
<b>Temperature</b>					
T <sub>j</sub>	Junction temperature operating range for commercial (C) temperature devices	0	–	85	°C
	Junction temperature operating range for extended (E) temperature devices	0	–	100	°C
	Junction temperature operating range for industrial (I) temperature devices	–40	–	100	°C

**Notes:**

- All voltages are relative to ground.
- For the design of the power distribution system, consult the *7 Series FPGAs PCB Design and Pin Planning Guide* (UG483).
- V<sub>CCINT</sub> and V<sub>CCBRAM</sub> should be connected to the same supply.
- For more information on the VID bit see the *Lowering Power using the Voltage Identification Bit* application note (XAPP555).
- Configuration data is retained even if V<sub>CCO</sub> drops to 0V.
- Includes V<sub>CCO</sub> of 1.2V, 1.5V, 1.8V, 2.5V, and 3.3V.
- The lower absolute voltage specification always applies.
- See Table 10 for TMDS\_33 specifications.
- A total of 200 mA per bank should not be exceeded.
- V<sub>CCBATT</sub> is required only when using bitstream encryption. If battery is not used, connect V<sub>CCBATT</sub> to either ground or V<sub>CCAUX</sub>.
- Each voltage listed requires the filter circuit described in the *7 Series FPGAs GTX/GTH Transceiver User Guide* (UG476).
- For data rates ≤ 10.3125 Gb/s, V<sub>MGTAVCC</sub> should be 1.0V ±3% for lower power consumption.
- For lower power consumption, V<sub>MGTAVCC</sub> should be 1.0V ±3% over the entire CPLL frequency range.

Table 3: DC Characteristics Over Recommended Operating Conditions

Symbol	Description	Min	Typ <sup>(1)</sup>	Max	Units
V <sub>DRINT</sub>	Data retention V <sub>CCINT</sub> voltage (below which configuration data might be lost)	0.75	–	–	V
V <sub>DRI</sub>	Data retention V <sub>CCAUX</sub> voltage (below which configuration data might be lost)	1.5	–	–	V
I <sub>REF</sub>	V <sub>REF</sub> leakage current per pin	–	–	15	µA
I <sub>L</sub>	Input or output leakage current per pin (sample-tested)	–	–	15	µA
C <sub>IN</sub> <sup>(2)</sup>	Die input capacitance at the pad	–	–	8	pF
I <sub>RPU</sub>	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 3.3V	90	–	330	µA
	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 2.5V	68	–	250	µA
	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 1.8V	34	–	220	µA
	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 1.5V	23	–	150	µA
	Pad pull-up (when selected) @ V <sub>IN</sub> = 0V, V <sub>CCO</sub> = 1.2V	12	–	120	µA

**Table 3: DC Characteristics Over Recommended Operating Conditions (Cont'd)**

Symbol	Description	Min	Typ <sup>(1)</sup>	Max	Units
I <sub>RPD</sub>	Pad pull-down (when selected) @ V <sub>IN</sub> = 3.3V	68	–	330	μA
	Pad pull-down (when selected) @ V <sub>IN</sub> = 1.8V	45	–	180	μA
I <sub>CCADC</sub>	Analog supply current, analog circuits in powered up state	–	–	25	mA
I <sub>BATT</sub> <sup>(3)</sup>	Battery supply current	–	–	150	nA
R <sub>IN_TERM</sub> <sup>(4)</sup>	Thevenin equivalent resistance of programmable input termination to V <sub>CCO</sub> /2 (UNTUNED_SPLIT_40) for commercial (C), industrial (I), and extended (E) temperature devices	28	40	55	Ω
	Thevenin equivalent resistance of programmable input termination to V <sub>CCO</sub> /2 (UNTUNED_SPLIT_50) for commercial (C), industrial (I), and extended (E) temperature devices	35	50	65	Ω
	Thevenin equivalent resistance of programmable input termination to V <sub>CCO</sub> /2 (UNTUNED_SPLIT_60) for commercial (C), industrial (I), and extended (E) temperature devices	44	60	83	Ω
n	Temperature diode ideality factor	–	1.010	–	–
r	Temperature diode series resistance	–	2	–	Ω

**Notes:**

1. Typical values are specified at nominal voltage, 25°C.
2. This measurement represents the die capacitance at the pad, not including the package.
3. Maximum value specified for worst case process at 25°C.
4. Termination resistance to a V<sub>CCO</sub>/2 level.

**Table 4: V<sub>IN</sub> Maximum Allowed AC Voltage Overshoot and Undershoot for 3.3V HR I/O Banks<sup>(1)</sup>**

AC Voltage Overshoot	% of UI @–40°C to 100°C	AC Voltage Undershoot	% of UI @–40°C to 100°C
V <sub>CCO</sub> + 0.55	100	–0.40	100
		–0.45	61.7
		–0.50	25.8
		–0.55	11.0
V <sub>CCO</sub> + 0.60	46.6	–0.60	4.77
V <sub>CCO</sub> + 0.65	21.2	–0.65	2.10
V <sub>CCO</sub> + 0.70	9.75	–0.70	0.94
V <sub>CCO</sub> + 0.75	4.55	–0.75	0.43
V <sub>CCO</sub> + 0.80	2.15	–0.80	0.20
V <sub>CCO</sub> + 0.85	1.02	–0.85	0.09
V <sub>CCO</sub> + 0.90	0.49	–0.90	0.04
V <sub>CCO</sub> + 0.95	0.24	–0.95	0.02

**Notes:**

1. A total of 200 mA per bank should not be exceeded.

**Table 6: Typical Quiescent Supply Current (Cont'd)**

Symbol	Description	Device	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
I <sub>CCAUXQ</sub>	Quiescent V <sub>CCAUX</sub> supply current	XC7V585T	114	114	114	mA
		XC7V2000T	N/A	315	315	mA
		XC7VX330T	73	73	73	mA
		XC7VX415T	88	88	88	mA
		XC7VX485T	104	104	104	mA
		XC7VX550T	147	147	147	mA
		XC7VX690T	147	147	147	mA
		XC7VX980T	N/A	183	183	mA
		XC7VX1140T	N/A	250	250	mA
I <sub>CCAUX_IOQ</sub>	Quiescent V <sub>CCAUX_IO</sub> supply current	XC7V585T	2	2	2	mA
		XC7V2000T	N/A	2	2	mA
		XC7VX330T	2	2	2	mA
		XC7VX415T	2	2	2	mA
		XC7VX485T	2	2	2	mA
		XC7VX550T	2	2	2	mA
		XC7VX690T	2	2	2	mA
		XC7VX980T	N/A	2	2	mA
		XC7VX1140T	N/A	2	2	mA
I <sub>CCBRAMQ</sub>	Quiescent V <sub>CCBRAM</sub> supply current	XC7V585T	34	34	34	mA
		XC7V2000T	N/A	56	56	mA
		XC7VX330T	32	32	32	mA
		XC7VX415T	38	38	38	mA
		XC7VX485T	44	44	44	mA
		XC7VX550T	63	63	63	mA
		XC7VX690T	63	63	63	mA
		XC7VX980T	N/A	65	65	mA
		XC7VX1140T	N/A	81	81	mA

**Notes:**

1. Typical values are specified at nominal voltage, 85°C junction temperatures (T<sub>j</sub>) with single-ended SelectIO resources.
2. Typical values are for blank configured devices with no output current loads, no active input pull-up resistors, all I/O pins are 3-state and floating.
3. Use the Xilinx Power Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate static power consumption for conditions other than those specified.

## DC Input and Output Levels

Values for  $V_{IL}$  and  $V_{IH}$  are recommended input voltages. Values for  $I_{OL}$  and  $I_{OH}$  are guaranteed over the recommended operating conditions at the  $V_{OL}$  and  $V_{OH}$  test points. Only selected standards are tested. These are chosen to ensure that all standards meet their specifications. The selected standards are tested at a minimum  $V_{CCO}$  with the respective  $V_{OL}$  and  $V_{OH}$  voltage levels shown. Other standards are sample tested.

**Table 9: SelectIO DC Input and Output Levels<sup>(1)(2)</sup>**

I/O Standard	$V_{IL}$		$V_{IH}$		$V_{OL}$	$V_{OH}$	$I_{OL}$	$I_{OH}$
	V, Min	V, Max	V, Min	V, Max	V, Max	V, Min	mA	mA
HSTL_I	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8	-8
HSTL_I_12	-0.300	$V_{REF} - 0.080$	$V_{REF} + 0.080$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	6.3	-6.3
HSTL_I_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	8	-8
HSTL_II	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16	-16
HSTL_II_18	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	16	-16
HSUL_12	-0.300	$V_{REF} - 0.130$	$V_{REF} + 0.130$	$V_{CCO} + 0.300$	20% $V_{CCO}$	80% $V_{CCO}$	0.1	-0.1
LVC MOS12	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 3	Note 3
LVC MOS15, LVDCI_15	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	25% $V_{CCO}$	75% $V_{CCO}$	Note 4	Note 4
LVC MOS18, LVDCI_18	-0.300	35% $V_{CCO}$	65% $V_{CCO}$	$V_{CCO} + 0.300$	0.450	$V_{CCO} - 0.450$	Note 5	Note 5
LVC MOS25	-0.300	0.700	1.700	$V_{CCO} + 0.300$	0.400	$V_{CCO} - 0.400$	Note 6	Note 6
LVC MOS33	-0.300	0.800	2.000	3.450	0.400	$V_{CCO} - 0.400$	Note 6	Note 6
LV TTL	-0.300	0.800	2.000	3.450	0.400	2.400	Note 7	Note 7
MOBILE_DDR	-0.300	20% $V_{CCO}$	80% $V_{CCO}$	$V_{CCO} + 0.300$	10% $V_{CCO}$	90% $V_{CCO}$	0.1	-0.1
PCI33_3	-0.400	30% $V_{CCO}$	50% $V_{CCO}$	$V_{CCO} + 0.500$	10% $V_{CCO}$	90% $V_{CCO}$	1.5	-0.5
SSTL12	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	14.25	-14.25
SSTL135	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	13.0	-13.0
SSTL135_R	-0.300	$V_{REF} - 0.090$	$V_{REF} + 0.090$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.150$	$V_{CCO}/2 + 0.150$	8.9	-8.9
SSTL15	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	13.0	-13.0
SSTL15_R	-0.300	$V_{REF} - 0.100$	$V_{REF} + 0.100$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.175$	$V_{CCO}/2 + 0.175$	8.9	-8.9
SSTL18_I	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.470$	$V_{CCO}/2 + 0.470$	8	-8
SSTL18_II	-0.300	$V_{REF} - 0.125$	$V_{REF} + 0.125$	$V_{CCO} + 0.300$	$V_{CCO}/2 - 0.600$	$V_{CCO}/2 + 0.600$	13.4	-13.4

**Notes:**

1. Tested according to relevant specifications.
2. 3.3V and 2.5V standards are only supported in 3.3V I/O banks.
3. Supported drive strengths of 2, 4, 6, or 8 mA in HP I/O banks and 4, 8, or 12 mA in HR I/O banks.
4. Supported drive strengths of 2, 4, 6, 8, 12, or 16 mA in HP I/O banks and 4, 8, 12, or 16 mA in HR I/O banks.
5. Supported drive strengths of 2, 4, 6, 8, 12, or 16 mA in HP I/O banks and 4, 8, 12, 16, or 24 mA in HR I/O banks.
6. Supported drive strengths of 4, 8, 12, or 16 mA
7. Supported drive strengths of 4, 8, 12, 16, or 24 mA
8. For detailed interface specific DC voltage levels, see the *7 Series FPGAs SelectIO Resources User Guide* ([UG471](#)).

Table 10: Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>			V <sub>OCM</sub> <sup>(3)</sup>			V <sub>OD</sub> <sup>(4)</sup>		
	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max	V, Min	V, Typ	V, Max
BLVDS_25	0.300	1.200	1.425	0.100	–	–	–	1.250	–	Note 5		
MINI_LVDS_25	0.300	1.200	V <sub>CCAUX</sub>	0.200	0.400	0.600	1.000	1.200	1.400	0.300	0.450	0.600
PPDS_25	0.200	0.900	V <sub>CCAUX</sub>	0.100	0.250	0.400	0.500	0.950	1.400	0.100	0.250	0.400
RSDS_25	0.300	0.900	1.500	0.100	0.350	0.600	1.000	1.200	1.400	0.100	0.350	0.600
TMDS_33	2.700	2.965	3.230	0.150	0.675	1.200	V <sub>CCO</sub> -0.405	V <sub>CCO</sub> -0.300	V <sub>CCO</sub> -0.190	0.400	0.600	0.800

Notes:

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OCM</sub> is the output common mode voltage.
4. V<sub>OD</sub> is the output differential voltage (Q –  $\bar{Q}$ ).
5. V<sub>OD</sub> for BLVDS will vary significantly depending on topology and loading.
6. LVDS\_25 is specified in Table 12.
7. LVDS is specified in Table 13.

Table 11: Complementary Differential SelectIO DC Input and Output Levels

I/O Standard	V <sub>ICM</sub> <sup>(1)</sup>			V <sub>ID</sub> <sup>(2)</sup>		V <sub>OL</sub> <sup>(3)</sup>	V <sub>OH</sub> <sup>(4)</sup>	I <sub>OL</sub>	I <sub>OH</sub>
	V, Min	V, Typ	V, Max	V, Min	V, Max	V, Max	V, Min	mA, Max	mA, Min
DIFF_HSTL_I	0.300	0.750	1.125	0.100	–	0.400	V <sub>CCO</sub> -0.400	8.00	-8.00
DIFF_HSTL_I_18	0.300	0.900	1.425	0.100	–	0.400	V <sub>CCO</sub> -0.400	8.00	-8.00
DIFF_HSTL_II	0.300	0.750	1.125	0.100	–	0.400	V <sub>CCO</sub> -0.400	16.00	-16.00
DIFF_HSTL_II_18	0.300	0.900	1.425	0.100	–	0.400	V <sub>CCO</sub> -0.400	16.00	-16.00
DIFF_HSUL_12	0.300	0.600	0.850	0.100	–	20% V <sub>CCO</sub>	80% V <sub>CCO</sub>	0.100	-0.100
DIFF_MOBILE_DDR	0.300	0.900	1.425	0.100	–	10% V <sub>CCO</sub>	90% V <sub>CCO</sub>	0.100	-0.100
DIFF_SSTL12	0.300	0.600	0.850	0.100	–	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	14.25	-14.25
DIFF_SSTL135	0.300	0.675	1.000	0.100	–	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	13.0	-13.0
DIFF_SSTL135_R	0.300	0.675	1.000	0.100	–	(V <sub>CCO</sub> /2) – 0.150	(V <sub>CCO</sub> /2) + 0.150	8.9	-8.9
DIFF_SSTL15	0.300	0.750	1.125	0.100	–	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	13.0	-13.0
DIFF_SSTL15_R	0.300	0.750	1.125	0.100	–	(V <sub>CCO</sub> /2) – 0.175	(V <sub>CCO</sub> /2) + 0.175	8.9	-8.9
DIFF_SSTL18_I	0.300	0.900	1.425	0.100	–	(V <sub>CCO</sub> /2) – 0.470	(V <sub>CCO</sub> /2) + 0.470	8.00	-8.00
DIFF_SSTL18_II	0.300	0.900	1.425	0.100	–	(V <sub>CCO</sub> /2) – 0.600	(V <sub>CCO</sub> /2) + 0.600	13.4	-13.4

Notes:

1. V<sub>ICM</sub> is the input common mode voltage.
2. V<sub>ID</sub> is the input differential voltage (Q –  $\bar{Q}$ ).
3. V<sub>OL</sub> is the single-ended low-output voltage.
4. V<sub>OH</sub> is the single-ended high-output voltage.

## Performance Characteristics

This section provides the performance characteristics of some common functions and designs implemented in Virtex-7 T and XT devices. The numbers reported here are worst-case values; they have all been fully characterized. These values are subject to the same guidelines as the [AC Switching Characteristics, page 12](#). In each table, the I/O bank type is either High Performance (HP) or High Range (HR).

*Table 17: Networking Applications Interface Performances*

Description	I/O Bank Type	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
SDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 8)	HR	710	710	625	Mb/s
	HP	710	710	625	Mb/s
DDR LVDS transmitter (using OSERDES; DATA_WIDTH = 4 to 14)	HR	1250	1250	950	Mb/s
	HP	1600	1400	1250	Mb/s
SDR LVDS receiver (SFI-4.1) <sup>(1)</sup>	HR	710	710	625	Mb/s
	HP	710	710	625	Mb/s
DDR LVDS receiver (SPI-4.2) <sup>(1)</sup>	HR	1250	1250	950	Mb/s
	HP	1600	1400	1250	Mb/s

**Notes:**

1. LVDS receivers are typically bounded with certain applications where specific dynamic phase-alignment (DPA) algorithms dominate deterministic performance.

**Table 20: 1.8V IOB High Performance (HP) Switching Characteristics**

I/O Standard	T <sub>IOPI</sub>			T <sub>IOOP</sub>			T <sub>IOTP</sub>			Units
	Speed Grade			Speed Grade			Speed Grade			
	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	-3	-2/-2L/-2G	-1	
LVDS	0.75	0.79	0.92	1.05	1.17	1.24	1.68	1.92	2.06	ns
HSUL_12	0.69	0.72	0.82	1.65	1.84	2.05	2.29	2.59	2.87	ns
DIFF_HSUL_12	0.69	0.72	0.82	1.65	1.84	2.05	2.29	2.59	2.87	ns
HSTL_I_S	0.68	0.72	0.82	1.15	1.28	1.38	1.79	2.03	2.20	ns
HSTL_II_S	0.68	0.72	0.82	1.05	1.17	1.26	1.69	1.93	2.08	ns
HSTL_I_18_S	0.70	0.72	0.82	1.12	1.24	1.34	1.75	2.00	2.16	ns
HSTL_II_18_S	0.70	0.72	0.82	1.06	1.18	1.26	1.70	1.94	2.08	ns
HSTL_I_12_S	0.68	0.72	0.82	1.14	1.27	1.37	1.78	2.02	2.20	ns
HSTL_I_DCI_S	0.68	0.72	0.82	1.11	1.23	1.33	1.74	1.99	2.15	ns
HSTL_II_DCI_S	0.68	0.72	0.82	1.05	1.17	1.26	1.69	1.93	2.08	ns
HSTL_II_T_DCI_S	0.70	0.72	0.82	1.15	1.28	1.38	1.78	2.03	2.20	ns
HSTL_I_DCI_18_S	0.70	0.72	0.82	1.11	1.23	1.33	1.74	1.99	2.15	ns
HSTL_II_DCI_18_S	0.70	0.72	0.82	1.05	1.16	1.24	1.69	1.92	2.06	ns
HSTL_II_T_DCI_18_S	0.70	0.72	0.82	1.11	1.23	1.33	1.74	1.99	2.15	ns
DIFF_HSTL_I_S	0.75	0.79	0.92	1.15	1.28	1.38	1.79	2.03	2.20	ns
DIFF_HSTL_II_S	0.75	0.79	0.92	1.05	1.17	1.26	1.69	1.93	2.08	ns
DIFF_HSTL_I_DCI_S	0.75	0.79	0.92	1.15	1.28	1.38	1.78	2.03	2.20	ns
DIFF_HSTL_II_DCI_S	0.75	0.79	0.92	1.05	1.17	1.26	1.69	1.93	2.08	ns
DIFF_HSTL_I_18_S	0.75	0.79	0.92	1.12	1.24	1.34	1.75	2.00	2.16	ns
DIFF_HSTL_II_18_S	0.75	0.79	0.92	1.06	1.18	1.26	1.70	1.94	2.08	ns
DIFF_HSTL_I_DCI_18_S	0.75	0.79	0.92	1.11	1.23	1.33	1.74	1.99	2.15	ns
DIFF_HSTL_II_DCI_18_S	0.75	0.79	0.92	1.05	1.16	1.24	1.69	1.92	2.06	ns
DIFF_HSTL_II_T_DCI_18_S	0.75	0.79	0.92	1.11	1.23	1.33	1.74	1.99	2.15	ns
HSTL_I_F	0.68	0.72	0.82	1.02	1.14	1.22	1.66	1.90	2.04	ns
HSTL_II_F	0.68	0.72	0.82	0.97	1.08	1.15	1.61	1.84	1.97	ns
HSTL_I_18_F	0.70	0.72	0.82	1.04	1.16	1.24	1.68	1.91	2.06	ns
HSTL_II_18_F	0.70	0.72	0.82	0.98	1.09	1.16	1.62	1.85	1.98	ns
HSTL_I_12_F	0.68	0.72	0.82	1.02	1.13	1.21	1.65	1.88	2.03	ns
HSTL_I_DCI_F	0.68	0.72	0.82	1.04	1.16	1.24	1.67	1.91	2.06	ns
HSTL_II_DCI_F	0.68	0.72	0.82	0.97	1.08	1.15	1.61	1.84	1.97	ns
HSTL_II_T_DCI_F	0.70	0.72	0.82	1.02	1.14	1.22	1.66	1.90	2.04	ns
HSTL_I_DCI_18_F	0.70	0.72	0.82	1.04	1.16	1.24	1.67	1.91	2.06	ns
HSTL_II_DCI_18_F	0.70	0.72	0.82	0.98	1.09	1.16	1.61	1.85	1.98	ns
HSTL_II_T_DCI_18_F	0.70	0.72	0.82	1.04	1.16	1.24	1.67	1.91	2.06	ns
DIFF_HSTL_I_F	0.75	0.79	0.92	1.02	1.14	1.22	1.66	1.90	2.04	ns
DIFF_HSTL_II_F	0.75	0.79	0.92	0.97	1.08	1.15	1.61	1.84	1.97	ns
DIFF_HSTL_I_DCI_F	0.75	0.79	0.92	1.02	1.14	1.22	1.66	1.90	2.04	ns
DIFF_HSTL_II_DCI_F	0.75	0.79	0.92	0.97	1.08	1.15	1.61	1.84	1.97	ns

## Input/Output Logic Switching Characteristics

Table 22: ILOGIC Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Setup/Hold</b>					
$T_{ICE1CK}/T_{ICKCE1}$	CE1 pin setup/hold with respect to CLK	0.42/0.00	0.48/0.00	0.67/0.00	ns
$T_{ISRCK}/T_{ICKSR}$	SR pin setup/hold with respect to CLK	0.53/0.01	0.61/0.01	0.99/0.01	ns
$T_{IDOCKE2}/T_{IOCKDE2}$	D pin setup/hold with respect to CLK without delay (HP I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	ns
$T_{IDOCKDE2}/T_{IOCKDDE2}$	DDLY pin setup/hold with respect to CLK (using IDELAY) (HP I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	ns
$T_{IDOCKE3}/T_{IOCKDE3}$	D pin setup/hold with respect to CLK without delay (HR I/O banks only)	0.01/0.27	0.01/0.29	0.01/0.34	ns
$T_{IDOCKDE3}/T_{IOCKDDE3}$	DDLY pin setup/hold with respect to CLK (using IDELAY) (HR I/O banks only)	0.01/0.27	0.02/0.29	0.02/0.34	ns
<b>Combinatorial</b>					
$T_{IDIE2}$	D pin to O pin propagation delay, no delay (HP I/O banks only)	0.09	0.10	0.12	ns
$T_{IDIDE2}$	DDLY pin to O pin propagation delay (using IDELAY) (HP I/O banks only)	0.10	0.11	0.13	ns
$T_{IDIE3}$	D pin to O pin propagation delay, no delay (HR I/O banks only)	0.09	0.10	0.12	ns
$T_{IDIDE3}$	DDLY pin to O pin propagation delay (using IDELAY) (HR I/O banks only)	0.10	0.11	0.13	ns
<b>Sequential Delays</b>					
$T_{IDLOE2}$	D pin to Q1 pin using flip-flop as a latch without delay (HP I/O banks only)	0.36	0.39	0.45	ns
$T_{IDLDE2}$	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HP I/O banks only)	0.36	0.39	0.45	ns
$T_{IDLOE3}$	D pin to Q1 pin using flip-flop as a latch without delay (HR I/O banks only)	0.36	0.39	0.45	ns
$T_{IDLDE3}$	DDLY pin to Q1 pin using flip-flop as a latch (using IDELAY) (HR I/O banks only)	0.36	0.39	0.45	ns
$T_{ICKQ}$	CLK to Q outputs	0.47	0.50	0.58	ns
$T_{RQ\_ILOGICE2}$	SR pin to OQ/TQ out (HP I/O banks only)	0.84	0.94	1.16	ns
$T_{GSRQ\_ILOGICE2}$	Global set/reset to Q outputs (HP I/O banks only)	7.60	7.60	10.51	ns
$T_{RQ\_ILOGICE3}$	SR pin to OQ/TQ out (HR I/O banks only)	0.84	0.94	1.16	ns
$T_{GSRQ\_ILOGICE3}$	Global set/reset to Q outputs (HR I/O banks only)	7.60	7.60	10.51	ns
<b>Set/Reset</b>					
$T_{RPW\_ILOGICE2}$	Minimum pulse width, SR inputs (HP I/O banks only)	0.54	0.63	0.63	ns, Min
$T_{RPW\_ILOGICE3}$	Minimum pulse width, SR inputs (HR I/O banks only)	0.54	0.63	0.63	ns, Min

**CLB Distributed RAM Switching Characteristics (SLICEM Only)**

Table 29: CLB Distributed RAM Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Sequential Delays</b>					
$T_{SHCKO}^{(1)}$	Clock to A – B outputs	0.68	0.70	0.85	ns, Max
$T_{SHCKO\_1}$	Clock to AMUX – BMUX outputs	0.91	0.95	1.15	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>					
$T_{DS\_L\text{RAM}}/T_{DH\_L\text{RAM}}$	A – D inputs to CLK	0.45/0.23	0.45/0.24	0.54/0.27	ns, Min
$T_{AS\_L\text{RAM}}/T_{AH\_L\text{RAM}}$	Address An inputs to clock	0.13/0.50	0.14/0.50	0.17/0.58	ns, Min
	Address An inputs through MUXs and/or carry logic to clock	0.40/0.16	0.42/0.17	0.52/0.23	ns, Min
$T_{WS\_L\text{RAM}}/T_{WH\_L\text{RAM}}$	WE input to clock	0.29/0.09	0.30/0.09	0.36/0.09	ns, Min
$T_{CECK\_L\text{RAM}}/T_{CKCE\_L\text{RAM}}$	CE input to CLK	0.29/0.09	0.30/0.09	0.37/0.09	ns, Min
<b>Clock CLK</b>					
$T_{MPW}$	Minimum pulse width	0.68	0.77	0.91	ns, Min
$T_{MCP}$	Minimum clock period	1.35	1.54	1.82	ns, Min

**Notes:**

- $T_{SHCKO}$  also represents the CLK to XMUX output. Refer to the timing report for the CLK to XMUX path.

**CLB Shift Register Switching Characteristics (SLICEM Only)**

Table 30: CLB Shift Register Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
<b>Sequential Delays</b>					
$T_{REG}$	Clock to A – D outputs	0.96	0.98	1.20	ns, Max
$T_{REG\_MUX}$	Clock to AMUX – DMUX output	1.19	1.23	1.50	ns, Max
$T_{REG\_M31}$	Clock to DMUX output via M31 output	0.89	0.91	1.10	ns, Max
<b>Setup and Hold Times Before/After Clock CLK</b>					
$T_{WS\_SHFREG}/T_{WH\_SHFREG}$	WE input	0.26/0.09	0.27/0.09	0.33/0.09	ns, Min
$T_{CECK\_SHFREG}/T_{CKCE\_SHFREG}$	CE input to CLK	0.27/0.09	0.28/0.09	0.33/0.09	ns, Min
$T_{DS\_SHFREG}/T_{DH\_SHFREG}$	A – D inputs to CLK	0.28/0.26	0.28/0.26	0.33/0.30	ns, Min
<b>Clock CLK</b>					
$T_{MPW\_SHFREG}$	Minimum pulse width	0.55	0.65	0.78	ns, Min

**Table 37: Duty Cycle Distortion and Clock Tree Skew**

Symbol	Description	Device	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
T <sub>DCD_CLK</sub>	Global clock tree duty cycle distortion <sup>(1)</sup>	All	0.20	0.20	0.20	ns
T <sub>CKSKEW</sub>	Global clock tree skew <sup>(2)</sup>	XC7V585T	0.75	0.91	0.98	ns
		XC7V2000T	N/A	0.39	0.39	ns
		XC7VX330T	0.60	0.74	0.79	ns
		XC7VX415T	0.76	0.84	0.91	ns
		XC7VX485T	0.60	0.74	0.79	ns
		XC7VX550T	0.73	0.88	0.96	ns
		XC7VX690T	0.73	0.88	0.96	ns
		XC7VX980T	N/A	0.91	0.98	ns
		XC7VX1140T	N/A	0.39	0.39	ns
T <sub>DCD_BUFIO</sub>	I/O clock tree duty cycle distortion	All	0.12	0.12	0.12	ns
T <sub>BUFIOSKEW</sub>	I/O clock tree skew across one clock region	All	0.02	0.02	0.02	ns
T <sub>DCD_BUFR</sub>	Regional clock tree duty cycle distortion	All	0.15	0.15	0.15	ns

**Notes:**

1. These parameters represent the worst-case duty cycle distortion observable at the I/O flip-flops. For all I/O standards, IBIS can be used to calculate any additional duty cycle distortion that might be caused by asymmetrical rise/fall times.
2. The T<sub>CKSKEW</sub> value represents the worst-case clock-tree skew observable between sequential I/O elements in a single SLR. Significantly less clock-tree skew exists for I/O registers that are close to each other and fed by the same or adjacent clock-tree branches. Use the Xilinx Timing Analyzer tools to evaluate clock skew specific to your application.

## MMCM Switching Characteristics

**Table 38: MMCM Specification**

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
MMCM_F <sub>INMAX</sub>	Maximum input clock frequency	1066.00	933.00	800.00	MHz
MMCM_F <sub>INMIN</sub>	Minimum input clock frequency	10	10	10	MHz
MMCM_F <sub>INJITTER</sub>	Maximum input clock period jitter	< 20% of clock input period or 1 ns Max			
MMCM_F <sub>INDUTY</sub>	Allowable input duty cycle: 10—49 MHz	25	25	25	%
	Allowable input duty cycle: 50—199 MHz	30	30	30	%
	Allowable input duty cycle: 200—399 MHz	35	35	35	%
	Allowable input duty cycle: 400—499 MHz	40	40	40	%
	Allowable input duty cycle: >500 MHz	45	45	45	%
MMCM_F <sub>MIN_PSCLK</sub>	Minimum dynamic phase shift clock frequency	0.01	0.01	0.01	MHz
MMCM_F <sub>MAX_PSCLK</sub>	Maximum dynamic phase shift clock frequency	550.00	500.00	450.00	MHz
MMCM_F <sub>VCOMIN</sub>	Minimum MMCM VCO frequency	600.00	600.00	600.00	MHz
MMCM_F <sub>VCOMAX</sub>	Maximum MMCM VCO frequency	1600.00	1440.00	1200.00	MHz
MMCM_F <sub>BANDWIDTH</sub>	Low MMCM bandwidth at typical <sup>(1)</sup>	1.00	1.00	1.00	MHz
	High MMCM bandwidth at typical <sup>(1)</sup>	4.00	4.00	4.00	MHz
MMCM_T <sub>STATPHAOFFSET</sub>	Static phase offset of the MMCM outputs <sup>(2)</sup>	0.12	0.12	0.12	ns
MMCM_T <sub>OUTJITTER</sub>	MMCM output jitter	Note 3			
MMCM_T <sub>OUTDUTY</sub>	MMCM output clock duty cycle precision <sup>(4)</sup>	0.20	0.20	0.20	ns

**Table 38: MMCM Specification (Cont'd)**

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
MMCM_T <sub>LOCKMAX</sub>	MMCM maximum Lock Time	100	100	100	μs
MMCM_F <sub>OUTMAX</sub>	MMCM maximum output frequency	1066.00	933.00	800.00	MHz
MMCM_F <sub>OUTMIN</sub>	MMCM minimum output frequency <sup>(5)(6)</sup>	4.69	4.69	4.69	MHz
MMCM_T <sub>EXTFDVAR</sub>	External clock feedback variation	< 20% of clock input period or 1 ns Max			
MMCM_RST <sub>MINPULSE</sub>	Minimum reset pulse width	5.00	5.00	5.00	ns
MMCM_F <sub>PFDMAX</sub>	Maximum frequency at the phase frequency detector	550.00	500.00	450.00	MHz
MMCM_F <sub>PFDMIN</sub>	Minimum frequency at the phase frequency detector	10.00	10.00	10.00	MHz
MMCM_T <sub>FBDELAY</sub>	Maximum delay in the feedback path	3 ns Max or one CLKIN cycle			
<b>MMCM Switching Characteristics Setup and Hold</b>					
T <sub>MMCMDCK_PSEN</sub> / T <sub>MMCMCKD_PSEN</sub>	Setup and hold of phase-shift enable	1.04/0.00	1.04/0.00	1.04/0.00	ns
T <sub>MMCMDCK_PSINCDEC</sub> / T <sub>MMCMCKD_PSINCDEC</sub>	Setup and hold of phase-shift increment/decrement	1.04/0.00	1.04/0.00	1.04/0.00	ns
T <sub>MMCMCKO_PSDONE</sub>	Phase shift clock-to-out of PSDONE	0.59	0.68	0.81	ns
<b>Dynamic Reconfiguration Port (DRP) for MMCM Before and After DCLK</b>					
T <sub>MMCMDCK_DADDR</sub> / T <sub>MMCMCKD_DADDR</sub>	DADDR setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	ns, Min
T <sub>MMCMDCK_DI</sub> /T <sub>MMCMCKD_DI</sub>	DI setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	ns, Min
T <sub>MMCMDCK_DEN</sub> /T <sub>MMCMCKD_DEN</sub>	DEN setup/hold	1.76/0.00	1.97/0.00	2.29/0.00	ns, Min
T <sub>MMCMDCK_DWE</sub> /T <sub>MMCMCKD_DWE</sub>	DWE setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	ns, Min
T <sub>MMCMCKO_DRDY</sub>	CLK to out of DRDY	0.65	0.72	0.99	ns, Max
F <sub>DCK</sub>	DCLK frequency	200.00	200.00	200.00	MHz, Max

**Notes:**

1. The MMCM does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
2. The static offset is measured between any MMCM outputs with identical phase.
3. Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
4. Includes global clock buffer.
5. Calculated as  $F_{VCO}/128$  assuming output duty cycle is 50%.
6. When CLKOUT4\_CASCADE = TRUE, MMCM\_F<sub>OUTMIN</sub> is 0.036 MHz.

## PLL Switching Characteristics

Table 39: PLL Specification

Symbol	Description	Speed Grade			Units
		-3	-2/-2L/-2G	-1	
PLL_F <sub>INMAX</sub>	Maximum input clock frequency	1066.00	933.00	800.00	MHz
PLL_F <sub>INMIN</sub>	Minimum input clock frequency	19.00	19.00	19.00	MHz
PLL_F <sub>INJITTER</sub>	Maximum input clock period jitter	< 20% of clock input period or 1 ns Max			
PLL_F <sub>INDUTY</sub>	Allowable input duty cycle: 19—49 MHz	25	25	25	%
	Allowable input duty cycle: 50—199 MHz	30	30	30	%
	Allowable input duty cycle: 200—399 MHz	35	35	35	%
	Allowable input duty cycle: 400—499 MHz	40	40	40	%
	Allowable input duty cycle: >500 MHz	45	45	45	%
PLL_F <sub>VCOMIN</sub>	Minimum PLL VCO frequency	800.00	800.00	800.00	MHz
PLL_F <sub>VCOMAX</sub>	Maximum PLL VCO frequency	2133.00	1866.00	1600.00	MHz
PLL_F <sub>BANDWIDTH</sub>	Low PLL bandwidth at typical <sup>(1)</sup>	1.00	1.00	1.00	MHz
	High PLL bandwidth at typical <sup>(1)</sup>	4.00	4.00	4.00	MHz
PLL_T <sub>STATPHAOFFSET</sub>	Static phase offset of the PLL outputs <sup>(2)</sup>	0.12	0.12	0.12	ns
PLL_T <sub>OUTJITTER</sub>	PLL output jitter	Note 3			
PLL_T <sub>OUTDUTY</sub>	PLL output clock duty cycle precision <sup>(4)</sup>	0.20	0.20	0.20	ns
PLL_T <sub>LOCKMAX</sub>	PLL maximum lock time	100	100	100	μs
PLL_F <sub>OUTMAX</sub>	PLL maximum output frequency	1066.00	933.00	800.00	MHz
PLL_F <sub>OUTMIN</sub>	PLL minimum output frequency <sup>(5)</sup>	6.25	6.25	6.25	MHz
PLL_T <sub>EXTFDVAR</sub>	External clock feedback variation	< 20% of clock input period or 1 ns Max			
PLL_RST <sub>MINPULSE</sub>	Minimum reset pulse width	5.00	5.00	5.00	ns
PLL_F <sub>PFDMAX</sub>	Maximum frequency at the phase frequency detector	550.00	500.00	450.00	MHz
PLL_F <sub>PFDMIN</sub>	Minimum frequency at the phase frequency detector	19.00	19.00	19.00	MHz
PLL_T <sub>FBDELAY</sub>	Maximum delay in the feedback path	3 ns Max or one CLKIN cycle			
<b>Dynamic Reconfiguration Port (DRP) for PLL Before and After DCLK</b>					
T <sub>PLLDCK_DADDR</sub> /T <sub>PLLCKD_DADDR</sub>	DADDR setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	ns, Min
T <sub>PLLDCK_DI</sub> /T <sub>PLLCKD_DI</sub>	DI setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	ns, Min
T <sub>PLLDCK_DEN</sub> /T <sub>PLLCKD_DEN</sub>	DEN setup/hold	1.76/0.00	1.97/0.00	2.29/0.00	ns, Min
T <sub>PLLDCK_DWE</sub> /T <sub>PLLCKD_DWE</sub>	DWE setup/hold	1.25/0.15	1.40/0.15	1.63/0.15	ns, Min
T <sub>PLLCKO_DRDY</sub>	CLK to out of DRDY	0.65	0.72	0.99	ns, Max
F <sub>DCK</sub>	DCLK frequency	200.00	200.00	200.00	MHz, Max

### Notes:

- The PLL does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
- The static offset is measured between any PLL outputs with identical phase.
- Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
- Includes global clock buffer.
- Calculated as F<sub>VCO</sub>/128 assuming output duty cycle is 50%.

## Device Pin-to-Pin Output Parameter Guidelines

All devices are 100% functionally tested. Values are expressed in nanoseconds unless otherwise noted.

Table 40: Clock-Capable Clock Input to Output Delay Without MMCM/PLL (Near Clock Region)

Symbol	Description	Device	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>without</i> MMCM/PLL.						
T <sub>ICKOFF</sub>	Clock-capable clock input and OUTFF <i>without</i> MMCM/PLL (near clock region)	XC7V585T	5.63	6.20	6.97	ns
		XC7V2000T	N/A	5.66	6.35	ns
		XC7VX330T	5.41	5.97	6.71	ns
		XC7VX415T	5.46	5.96	6.70	ns
		XC7VX485T	5.29	5.84	6.57	ns
		XC7VX550T	5.45	6.02	6.76	ns
		XC7VX690T	5.46	6.02	6.76	ns
		XC7VX980T	N/A	6.12	6.87	ns
		XC7VX1140T	N/A	5.59	6.28	ns

**Notes:**

- Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net in a single SLR.

Table 41: Clock-Capable Clock Input to Output Delay Without MMCM/PLL (Far Clock Region)

Symbol	Description	Device	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
SSTL15 Clock-Capable Clock Input to Output Delay using Output Flip-Flop, Fast Slew Rate, <i>without</i> MMCM/PLL.						
T <sub>ICKOFFFAR</sub>	Clock-capable clock input and OUTFF <i>without</i> MMCM/PLL (far clock region)	XC7V585T	6.81	7.53	8.44	ns
		XC7V2000T	N/A	6.00	6.73	ns
		XC7VX330T	6.31	6.97	7.83	ns
		XC7VX415T	6.36	6.90	7.69	ns
		XC7VX485T	6.20	6.86	7.69	ns
		XC7VX550T	6.66	7.37	8.27	ns
		XC7VX690T	6.69	7.37	8.27	ns
		XC7VX980T	N/A	7.47	8.37	ns
		XC7VX1140T	N/A	5.93	6.65	ns

**Notes:**

- Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net in a single SLR.

Table 52 summarizes the DC specifications of the clock input of the GTX transceiver. Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide* ([UG476](#)) for further details.

Table 52: GTX Transceiver Clock DC Input Level Specification

Symbol	DC Parameter	Min	Typ	Max	Units
V <sub>IDIFF</sub>	Differential peak-to-peak input voltage	250	–	2000	mV
R <sub>IN</sub>	Differential input resistance	–	100	–	Ω
C <sub>EXT</sub>	Required external AC coupling capacitor	–	100	–	nF

## GTX Transceiver Switching Characteristics

Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide* ([UG476](#)) for further information.

Table 53: GTX Transceiver Performance

Symbol	Description	Output Divider	Speed Grade			Units
			-3/-2G	-2/-2L	-1 <sup>(1)</sup>	
F <sub>GTXMAX</sub> <sup>(2)</sup>	Maximum GTX transceiver data rate		12.5	10.3125	8.0	Gb/s
F <sub>GTXMIN</sub> <sup>(2)</sup>	Minimum GTX transceiver data rate		0.500	0.500	0.500	Gb/s
F <sub>GTXCRANGE</sub>	CPLL line rate range	1	3.2–6.6			Gb/s
		2	1.6–3.3			Gb/s
		4	0.8–1.65			Gb/s
		8	0.5–0.825			Gb/s
		16	N/A			Gb/s
F <sub>GTXQRANGE1</sub>	QPLL line rate range 1	1	5.93–8.0	5.93–8.0	5.93–8.0	Gb/s
		2	2.965–4.0	2.965–4.0	2.965–4.0	Gb/s
		4	1.4825–2.0	1.4825–2.0	1.4825–2.0	Gb/s
		8	0.74125–1.0	0.74125–1.0	0.74125–1.0	Gb/s
		16	N/A	N/A	N/A	Gb/s
F <sub>GTXQRANGE2</sub>	QPLL line rate range 2 <sup>(3)</sup>	1	9.8–12.5	9.8–10.3125	N/A	Gb/s
		2	4.9–6.25	4.9–5.15625	N/A	Gb/s
		4	2.45–3.125	2.45–2.578125	N/A	Gb/s
		8	1.225–1.5625	1.225–1.2890625	N/A	Gb/s
		16	0.6125–0.78125	0.6125–0.64453125	N/A	Gb/s
F <sub>GCPLL</sub> RANGE	GTX transceiver CPLL frequency range		1.6–3.3	1.6–3.3	1.6–3.3	GHz
F <sub>GQPLL</sub> RANGE1	GTX transceiver QPLL frequency range 1		5.93–8.0	5.93–8.0	5.93–8.0	GHz
F <sub>GQPLL</sub> RANGE2	GTX transceiver QPLL frequency range 2		9.8–12.5	9.8–10.3125	N/A	GHz

### Notes:

- The -1 speed grade requires a 4-byte internal data width for operation above 5.0 Gb/s. A -1 speed grade with V<sub>CCINT</sub> = 0.9V, as described in the *Lowering Power using the Voltage Identification Bit* application note ([XAPP555](#)), requires a 4-byte internal data width for operation above 3.8 Gb/s.
- Data rates between 8.0 Gb/s and 9.8 Gb/s are not available.
- For QPLL line rate range 2, the maximum line rate with the divider N set to 66 is 10.3125Gb/s.

Table 54: GTX Transceiver Dynamic Reconfiguration Port (DRP) Switching Characteristics

Symbol	Description	Speed Grade			Units
		-3/-2G	-2/-2L	-1	
F <sub>GTXDRPCLK</sub>	GTXDRPCLK maximum frequency	175.01	175.01	156.25	MHz

Table 55: GTX Transceiver Reference Clock Switching Characteristics

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
F <sub>GCLK</sub>	Reference clock frequency range	-3 speed grade	60	–	700	MHz
		All other speed grades	60	–	670	MHz
T <sub>RCLK</sub>	Reference clock rise time	20% – 80%	–	200	–	ps
T <sub>FCLK</sub>	Reference clock fall time	80% – 20%	–	200	–	ps
T <sub>DCREF</sub>	Reference clock duty cycle	Transceiver PLL only	40	50	60	%

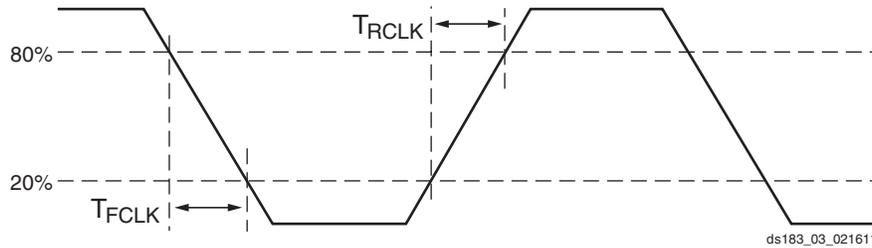


Figure 3: Reference Clock Timing Parameters

Table 56: GTX Transceiver PLL/Lock Time Adaptation

Symbol	Description	Conditions	All Speed Grades			Units
			Min	Typ	Max	
T <sub>LOCK</sub>	Initial PLL lock		–	–	1	ms
T <sub>DLOCK</sub>	Clock recovery phase acquisition and adaptation time for decision feedback equalizer (DFE).	After the PLL is locked to the reference clock, this is the time it takes to lock the clock data recovery (CDR) to the data present at the input.	–	50,000	37 x10 <sup>6</sup>	UI
	Clock recovery phase acquisition and adaptation time for low-power mode (LPM) when the DFE is disabled.		–	50,000	2.3 x10 <sup>6</sup>	UI

Table 59: GTX Transceiver Receiver Switching Characteristics

Symbol	Description		Min	Typ	Max	Units
F <sub>GTXRX</sub>	Serial data rate	RX oversampler not enabled	0.500	–	F <sub>GTXMAX</sub>	Gb/s
T <sub>RXELECIDLE</sub>	Time for RXELECIDLE to respond to loss or restoration of data		–	10	–	ns
RX <sub>OOBVDPP</sub>	OOB detect threshold peak-to-peak		60	–	150	mV
RX <sub>SST</sub>	Receiver spread-spectrum tracking <sup>(1)</sup>	Modulated @ 33 KHz	–5000	–	0	ppm
RX <sub>RL</sub>	Run length (CID)		–	–	512	UI
RX <sub>PPMTOL</sub>	Data/REFCLK PPM offset tolerance	Bit rates ≤ 6.6 Gb/s	–1250	–	1250	ppm
		Bit rates > 6.6 Gb/s and ≤ 8.0 Gb/s	–700	–	700	ppm
		Bit rates > 8.0 Gb/s	–200	–	200	ppm
<b>SJ Jitter Tolerance<sup>(2)</sup></b>						
JT_SJ <sub>12.5</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	12.5 Gb/s	0.3	–	–	UI
JT_SJ <sub>11.18</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	11.18 Gb/s	0.3	–	–	UI
JT_SJ <sub>10.32</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	10.32 Gb/s	0.3	–	–	UI
JT_SJ <sub>9.95</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	9.95 Gb/s	0.3	–	–	UI
JT_SJ <sub>9.8</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	9.8 Gb/s	0.3	–	–	UI
JT_SJ <sub>8.0</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	8.0 Gb/s	0.44	–	–	UI
JT_SJ <sub>6.6_QPLL</sub>	Sinusoidal jitter (QPLL) <sup>(3)</sup>	6.6 Gb/s	0.48	–	–	UI
JT_SJ <sub>6.6_CPLL</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	6.6 Gb/s	0.44	–	–	UI
JT_SJ <sub>5.0</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	5.0 Gb/s	0.44	–	–	UI
JT_SJ <sub>4.25</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	4.25 Gb/s	0.44	–	–	UI
JT_SJ <sub>3.75</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	3.75 Gb/s	0.44	–	–	UI
JT_SJ <sub>3.2</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	3.2 Gb/s <sup>(4)</sup>	0.45	–	–	UI
JT_SJ <sub>3.2L</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	3.2 Gb/s <sup>(5)</sup>	0.45	–	–	UI
JT_SJ <sub>2.5</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	2.5 Gb/s <sup>(6)</sup>	0.5	–	–	UI
JT_SJ <sub>1.25</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	1.25 Gb/s <sup>(7)</sup>	0.5	–	–	UI
JT_SJ <sub>500</sub>	Sinusoidal jitter (CPLL) <sup>(3)</sup>	500 Mb/s	0.4	–	–	UI
<b>SJ Jitter Tolerance with Stressed Eye<sup>(2)</sup></b>						
JT_TJSE <sub>3.2</sub>	Total jitter with stressed eye <sup>(8)</sup>	3.2 Gb/s	0.70	–	–	UI
JT_TJSE <sub>6.6</sub>		6.6 Gb/s	0.70	–	–	UI
JT_SJSE <sub>3.2</sub>	Sinusoidal jitter with stressed eye <sup>(8)</sup>	3.2 Gb/s	0.1	–	–	UI
JT_SJSE <sub>6.6</sub>		6.6 Gb/s	0.1	–	–	UI

**Notes:**

- Using RXOUT\_DIV = 1, 2, and 4.
- All jitter values are based on a bit error ratio of 1e<sup>-12</sup>.
- The frequency of the injected sinusoidal jitter is 80 MHz.
- CPLL frequency at 3.2 GHz and RXOUT\_DIV = 2.
- CPLL frequency at 1.6 GHz and RXOUT\_DIV = 1.
- CPLL frequency at 2.5 GHz and RXOUT\_DIV = 2.
- CPLL frequency at 2.5 GHz and RXOUT\_DIV = 4.
- Composite jitter with RX equalizer enabled. DFE disabled.

## GTH Transceiver Specifications

### GTH Transceiver DC Input and Output Levels

Table 66 summarizes the DC specifications of the GTH transceivers in Virtex-7 T and XT FPGAs. Consult the *7 Series FPGAs GTX/GTH Transceiver User Guide (UG476)* for further details.

Table 66: GTH Transceiver DC Specifications

Symbol	DC Parameter	Conditions	Min	Typ	Max	Units
DV <sub>PPIN</sub>	Differential peak-to-peak input voltage (external AC coupled)	>10.3125 Gb/s	150	–	1250	mV
		6.6 Gb/s to 10.3125 Gb/s	150	–	1250	mV
		≤ 6.6 Gb/s	150	–	2000	mV
V <sub>IN</sub>	Absolute input voltage	DC coupled V <sub>MGTAVTT</sub> = 1.2V	–400	–	V <sub>MGTAVTT</sub>	mV
V <sub>CMIN</sub>	Common mode input voltage	DC coupled V <sub>MGTAVTT</sub> = 1.2V	–	2/3 V <sub>MGTAVTT</sub>	–	mV
DV <sub>PPOUT</sub>	Differential peak-to-peak output voltage <sup>(1)</sup>	Transmitter output swing is set to 1010	–	–	800	mV
V <sub>CMOUTDC</sub>	Common mode output voltage: DC coupled	Equation based	$V_{MGTAVTT} - DV_{PPOUT}/4$			mV
V <sub>CMOUTAC</sub>	Common mode output voltage: AC coupled	Equation based	$V_{MGTAVTT} - DV_{PPOUT}/2$			mV
R <sub>IN</sub>	Differential input resistance		–	100	–	Ω
R <sub>OUT</sub>	Differential output resistance		–	100	–	Ω
T <sub>OSKEW</sub>	Transmitter output pair (TXP and TXN) intra-pair skew		–	–	10	ps
C <sub>EXT</sub>	Recommended external AC coupling capacitor <sup>(2)</sup>		–	100	–	nF

**Notes:**

1. The output swing and preemphasis levels are programmable using the attributes discussed in the *7 Series FPGAs GTX/GTH Transceiver User Guide (UG476)*, and can result in values lower than reported in this table.
2. Other values can be used as appropriate to conform to specific protocols and standards.

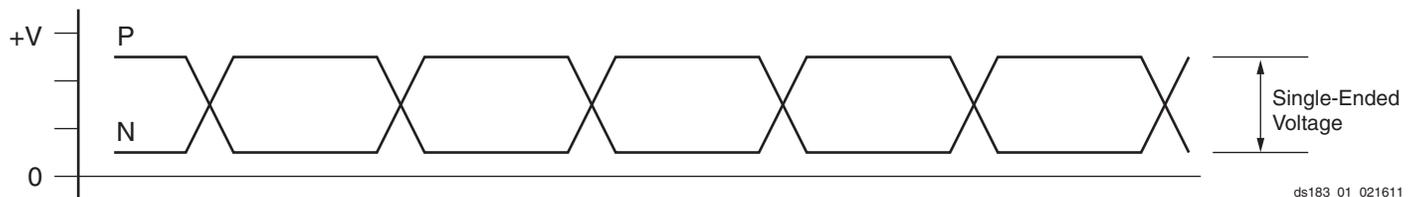


Figure 4: Single-Ended Peak-to-Peak Voltage

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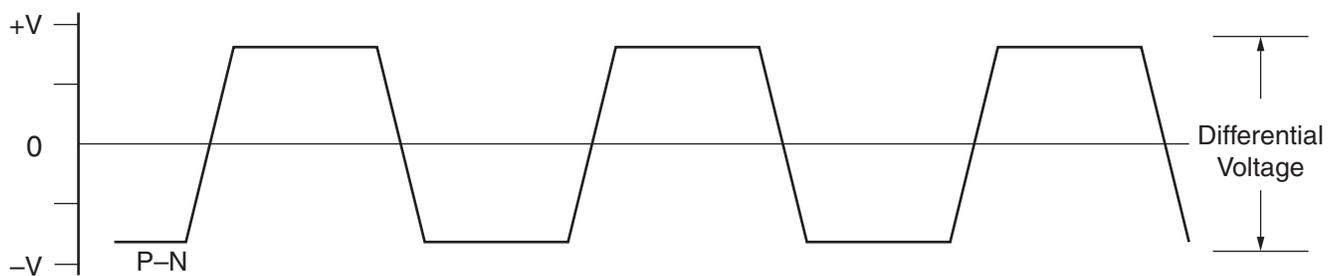


Figure 5: Differential Peak-to-Peak Voltage

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Table 83: Configuration Switching Characteristics (Cont'd)

Symbol	Description	Virtex-7 T and XT Devices	Speed Grade			Units
			-3	-2/-2L/-2G	-1	
<b>Master/Slave Serial Mode Programming Switching</b>						
$T_{DCCK}/T_{CCKD}$	DIN setup/hold		4.0/0.0	4.0/0.0	4.0/0.0	ns, Min
$T_{CCO}$	DOOUT clock to out		8.0	8.0	8.0	ns, Max
<b>SelectMAP Mode Programming Switching</b>						
$T_{SMDCCK}/T_{SMCCKD}$	D[31:00] setup/hold		4.0/0.0	4.0/0.0	4.0/0.0	ns, Min
$T_{SMCSCCK}/T_{SMCCKCS}$	CSI_B setup/hold		4.0/0.0	4.0/0.0	4.0/0.0	ns, Min
$T_{SMWCCK}/T_{SMCCKW}$	RDWR_B setup/hold		10.0/0.0	10.0/0.0	10.0/0.0	ns, Min
$T_{SMCKCSO}$	CSO_B clock to out (330 $\Omega$ pull-up resistor required)		7.0	7.0	7.0	ns, Max
$T_{SMCO}$	D[31:00] clock to out in readback		8.0	8.0	8.0	ns, Max
$F_{RBCK}$	Readback frequency	SLR-based	70	70	70	MHz, Max
		All other devices	100	100	100	MHz, Max
<b>Boundary-Scan Port Timing Specifications</b>						
$T_{TAPTCK}/T_{TCKTAP}$	TMS and TDI setup/hold	SLR-based	9.0/2.0	9.0/2.0	9.0/2.0	ns, Min
		All other devices	3.0/2.0	3.0/2.0	3.0/2.0	ns, Min
$T_{TCKTDO}$	TCK falling edge to TDO output	SLR-based	17	17	17	ns, Max
		All other devices	7.0	7.0	7.0	ns, Max
$F_{TCK}$	TCK frequency	SLR-based	20	20	20	MHz, Max
		All other devices	66	66	66	MHz, Max
<b>BPI Master Flash Mode Programming Switching</b>						
$T_{BPICCO}^{(2)}$	A[28:00], RS[1:0], FCS_B, FOE_B, FWE_B, ADV_B clock to out		8.5	8.5	8.5	ns, Max
$T_{BPIDCC}/T_{BPICCD}$	D[15:00] setup/hold		4.0/0.0	4.0/0.0	4.0/0.0	ns, Min
<b>SPI Master Flash Mode Programming Switching</b>						
$T_{SPIDCC}/T_{SPICCD}$	D[03:00] setup/hold		3.0/0.0	3.0/0.0	3.0/0.0	ns, Min
$T_{SPICCM}$	MOSI clock to out		8.0	8.0	8.0	ns, Max
$T_{SPICFC}$	FCS_B clock to out		8.0	8.0	8.0	ns, Max

**Notes:**

1. To support longer delays in configuration, use the design solutions described in the *7 Series FPGA Configuration User Guide* (UG470).
2. Only during configuration, the last edge is determined by a weak pull-up/pull-down resistor in the I/O.

## eFUSE Programming Conditions

Table 84 lists the programming conditions specifically for eFUSE. For more information, see the *7 Series FPGA Configuration User Guide* (UG470).

Table 84: eFUSE Programming Conditions<sup>(1)</sup>

Symbol	Description	Min	Typ	Max	Units
$I_{FS}$	$V_{CCAUX}$ supply current	–	–	115	mA
$t_j$	Temperature range	15	–	125	$^{\circ}C$

**Notes:**

1. The FPGA must not be configured during eFUSE programming.

Date	Version	Description
08/03/2012	1.5	<p>Updated the descriptions, changed <math>V_{IN}</math> and <a href="#">Note 2</a> and added <a href="#">Note 4</a> in <a href="#">Table 1</a>. In <a href="#">Table 2</a>, changed descriptions and notes, removed <a href="#">Note 7</a>, changed GTX transceiver parameters and values and added <a href="#">Note 12</a> and <a href="#">Note 13</a>. Updated parameters in <a href="#">Table 3</a>. Added <a href="#">Table 4</a> and <a href="#">Table 5</a>. Updated the values for in <a href="#">Table 7</a>. Updated LVCMOS12 and the SSTLs in <a href="#">Table 9</a>. Updated many of the specifications in <a href="#">Table 10</a> and <a href="#">Table 11</a>.</p> <p>Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a>, for the ISE 14.2 speed specifications throughout the document with appropriate changes to <a href="#">Table 15</a> and <a href="#">Table 16</a> including production release of the XC7VX485T in the -2 and -1 speed designations.</p> <p>Added notes and specifications to <a href="#">Table 18</a>. Updated the <a href="#">IOB Pad Input/Output/3-State</a> discussion and changed <a href="#">Table 21</a> by adding <math>T_{IOIBUFDISABLE}</math>.</p> <p>Removed many of the combinatorial delay specifications and <math>T_{CINCK}/T_{CKCIN}</math> from <a href="#">Table 28</a>.</p> <p>Rearranged <a href="#">Table 51</a> including moving some parameters to <a href="#">Table 1</a>. Added <a href="#">Table 56</a>. Updated <a href="#">Table 57</a>. In <a href="#">Table 59</a>, updated SJ Jitter Tolerance with Stressed Eye section, <a href="#">page 48</a> and <a href="#">Note 8</a>. Added <a href="#">Note 1</a>, <a href="#">Note 2</a>, and <a href="#">Note 3</a> to <a href="#">Table 62</a>. Added <a href="#">Note 1</a> and <a href="#">Note 2</a> to <a href="#">Table 63</a>, and line rate ranges. Updated <a href="#">Table 64</a> including adding <a href="#">Note 1</a>. Updated <a href="#">Table 65</a> including adding <a href="#">Note 1</a>. In <a href="#">Table 82</a> updated <a href="#">Note 1</a> and added <a href="#">Note 4</a>. In <a href="#">Table 83</a>, updated <math>T_{POR}</math> and <math>F_{EMCK}</math>.</p>
09/20/2012	1.6	<p>Removed the XC7V1500T device from data sheet. In <a href="#">Table 2</a>, revised <math>V_{CCINT}</math> and <math>V_{CCBRAM}</math> and added <a href="#">Note 3</a>. Updated some of the values in <a href="#">Table 7</a>. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7V585T in the -2 and -1 speed designations. Added values for the XC7V585T in <a href="#">Table 50</a>. Updated <a href="#">Note 2</a> in <a href="#">Table 58</a>.</p>
09/26/2012	1.7	<p>Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX485T in the -3 speed designation.</p>
10/19/2012	1.8	<p>Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX485T in the -2L (1.0V) speed designation.</p> <p>Removed -2L (0.9V) speed specifications from data sheet, this change includes edits to <math>V_{CCINT}</math> and <math>V_{CCBRAM}</math> in <a href="#">Table 2</a>, editing <a href="#">Note 1</a> and removing <a href="#">Note 2</a> in <a href="#">Table 53</a>. Also in <a href="#">Table 53</a>, updated the <math>F_{GTXMAX}</math>, <math>F_{GTXQRANGE1}</math>, and <math>F_{GQPLLRRANGE1}</math> specification for -1 speed grade from 6.6 Gb/s to 8.0 Gb/s. Edited <a href="#">Note 4</a> in <a href="#">Table 57</a> and <a href="#">Note 3</a> in <a href="#">Table 72</a>.</p>
12/12/2012	1.9	<p>Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a>, for the ISE 14.3 speed specifications throughout the document. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7V585T in the -3 and -2L(1.0V) speed designations. Updated the notes in <a href="#">Table 50</a>.</p> <p>Updated <a href="#">GTH Transceiver Specifications</a> including removal of GTH Transceiver DC Characteristics section (use the XPE (download at <a href="http://www.xilinx.com/power">http://www.xilinx.com/power</a>)). Updated <a href="#">Table 68</a> and added <a href="#">Table 71</a>, <a href="#">Table 73</a>, and <a href="#">Table 74</a>. Removed <a href="#">Note 4</a> from <a href="#">Table 82</a>.</p>
12/24/2012	1.10	<p>Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a>, for the ISE 14.4 and Vivado 2012.4 speed specifications throughout the document. Revised the XC7V2000T in the -1 and -2 speed designations <a href="#">Table 15</a> to preliminary.</p> <p>Added the <a href="#">GTH Transceiver Protocol Jitter Characteristics</a> section. Updated <math>T_{TCKTDO}</math> and added <a href="#">Internal Configuration Access Port</a> section to <a href="#">Table 83</a>.</p>
01/31/2013	1.11	<p>Added <a href="#">Note 2</a> to <a href="#">Table 2</a>. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7V2000T in the -1 and -2 speed specifications. Updated <a href="#">Note 1</a> in <a href="#">Table 35</a>. Updated the notes in <a href="#">Table 37</a>, <a href="#">Table 40</a> through <a href="#">Table 43</a>, <a href="#">Table 46</a>, and <a href="#">Table 47</a>. In <a href="#">Table 66</a>, updated <math>D_{VPPIN}</math>. In <a href="#">Table 67</a>, updated <math>V_{IDIFF}</math>. Removed <math>T_{LOCK}</math> and <math>T_{PHASE}</math> from <a href="#">Table 70</a>. Updated <math>T_{DLOCK}</math> in <a href="#">Table 71</a>.</p>
03/07/2013	1.12	<p>Updated the <a href="#">AC Switching Characteristics</a> section, based upon <a href="#">Table 14</a>, for the ISE 14.5 and Vivado 2013.1 speed specifications throughout the document. Revised <a href="#">Table 15</a> and <a href="#">Table 16</a> to include production release of the XC7VX690T.</p> <p>Revised <math>D_{VPPOUT}</math> in <a href="#">Table 66</a>. Updated values in <a href="#">Table 67</a> and <a href="#">Table 74</a>. Removed <a href="#">Note 1</a> from <a href="#">Table 68</a>. Updated <math>MMCM\_F_{PFDMAX}</math> in <a href="#">Table 38</a> and <math>PLL\_F_{PFDMAX}</math> in <a href="#">Table 39</a>. Added skew values to <a href="#">Table 50</a>.</p>